

Notice of References Cited	Application/Control No. 13/328,010	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2004/0057310 A1	03-2004	Hosono et al.	365/202
*	B US-2008/0080239 A1	04-2008	Shibata, Noboru	365/185.03
	C US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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